TOSHIBA Field Effect Transistor Silicon N Channel MOS Type (π -MOSIII⁻⁵)

2SK1486

Chopper Regulator, DC-DC Converter and Motor Drive Applications

 $\begin{array}{ll} \bullet & Low\ drain-source\ ON\ resistance & \vdots\ RDS\ (ON) = 0.08\ \Omega\ (typ.) \\ \bullet & High\ forward\ transfer\ admittance & \vdots\ |\ Y_{fs}\ | = 14\ S\ (typ.) \\ \bullet & Low\ leakage\ current & \vdots\ IDSS = 300\ \mu A\ (max)\ (VDS = 300\ V) \\ \bullet & Enhancement\ mode & \vdots\ V_{th} = 2.0 {\sim} 4.0\ V\ (VDS = 10\ V,\ ID = 1\ mA) \\ \end{array}$

Maximum Ratings (Ta = 25°C)

Characteri	stics	Symbol	Rating	Unit	
Drain-source voltage		V_{DSS}	300	V	
Drain-gate voltage (R	_{GS} = 20 kΩ)	V_{DGR}	300	V	
Gate-source voltage		V _{GSS}	±30	V	
Drain current	DC (Note 1)	I _D	32	Α	
	Pulse (Note 1)	I_{DP}	128		
Drain power dissipatio	n (Tc = 25°C)	P_{D}	200	W	
Channel temperature		T _{ch}	150	°C	
Storage temperature r	ange	T _{stg}	-55~150	°C	

Thermal Characteristics

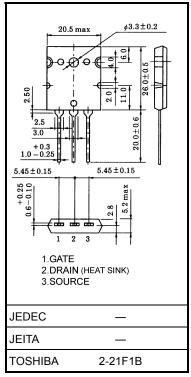
Characteristics	Symbol	Max	Unit
Thermal resistance, channel to case	R _{th (ch-c)}	0.625	°C/W
Thermal resistance, channel to ambient	R _{th (ch-a)}	35.7	°C/W

Note 1: Ensure that the channel temperature does not exceed 150°C.

This transistor is an electrostatic-sensitive device.

Please handle with caution.

Unit: mm



Weight: 9.75 g (typ.)



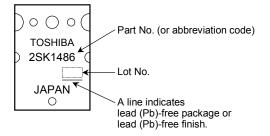
Electrical Characteristics (Ta = 25°C)

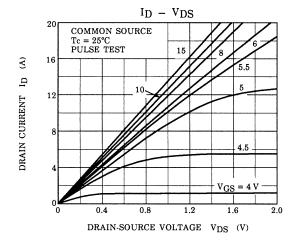
Charac	eteristics	Symbol	Test Condition	Min	Тур.	Max	Unit
Gate leakage cu	ırrent	I _{GSS}	V _{GS} = ±30 V, V _{DS} = 0 V	_	_	±100	nA
Drain cut-off cu	rrent	I _{DSS}	V _{DS} = 300 V, V _{GS} = 0 V	_	_	300	μΑ
Drain-source br	eakdown voltage	V (BR) DSS	I _D = 10 mA, V _{GS} = 0 V	300	_		V
Gate threshold v	/oltage	V _{th}	V _{DS} = 10 V, I _D = 1 mA	2.0	_	4.0	V
Drain-source O	N resistance	R _{DS (ON)}	I _D = 16 A, V _{GS} = 10 V	_	0.08	0.095	Ω
Forward transfer	r admittance	Y _{fs}	V _{DS} = 10 V, I _D = 16 A	10	14	_	S
Input capacitano	e	C _{iss}		_	3500		pF
Reverse transfe	r capacitance	C _{rss}	V _{DS} = 10 V, V _{GS} = 0 V, f = 1 MHz	-	800	-	
Output capacita	Output capacitance C _{oss}		_	1250			
Switching time Fa	Rise time	t _r	V_{GS} V_{OUT} V_{OUT} V_{DD} V_{DD}	_	255	_	
	Turn-on time	t _{on}		_	325		20
	Fall time	t _f		_	280	_	- ns
	Turn-off time	t _{off}	Duty \leq 1%, $t_{\rm W}$ = 10 μ s	_	540		
Total gate charge (Gate-source plus gate-drain)		Qg		_	140		
Gate-source charge		Q _{gs}	$V_{DD} \approx 240 \text{ V}, V_{GS} = 10 \text{ V}, I_D = 32 \text{ A}$		60	_	nC
Gate-drain ("miller") charge		Q_{gd}			80	_	

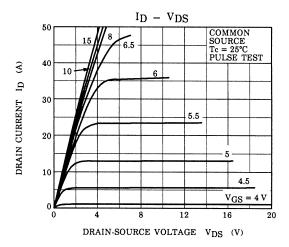
Source-Drain Ratings and Characteristics (Ta = 25°C)

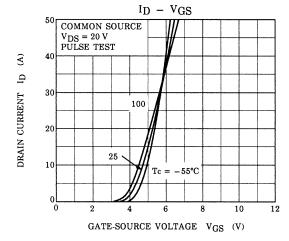
Characteristics	Symbol	Test Condition	Min	Тур.	Max	Unit
Continuous drain reverse current (Note 1)	I _{DR}	_	_	_	32	Α
Pulse drain reverse current (Note 1)	I _{DRP}	1	_	_	128	Α
Forward voltage (diode)	V _{DSF}	I _{DR} = 32 A, V _{GS} = 0 V	_	_	-1.8	V
Reverse recovery time	t _{rr}	I _{DR} = 32 A, V _{GS} = 0 V dI _{DR} / dt = 100 A / μs	1	615		ns
Reverse recovered charge	Q _{rr}	dI _{DR} / dt = 100 A / μs	1	6.8	1	μC

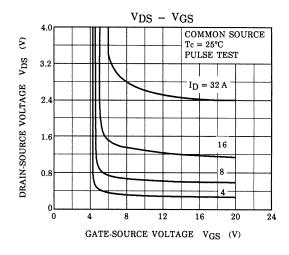
Marking

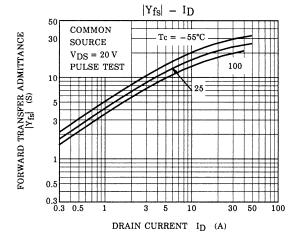


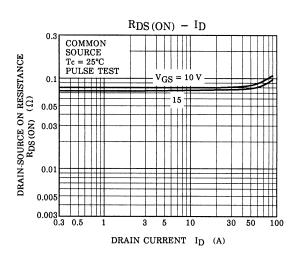


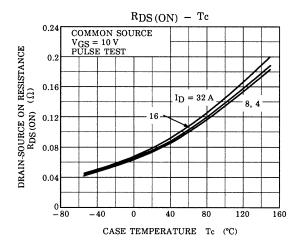


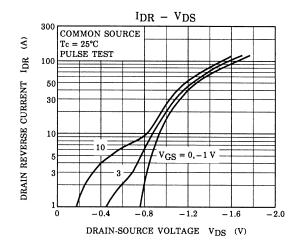


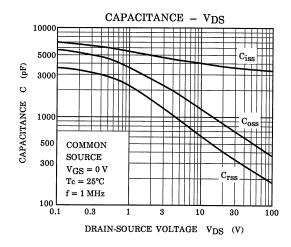


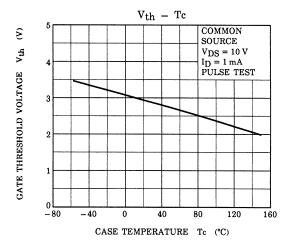


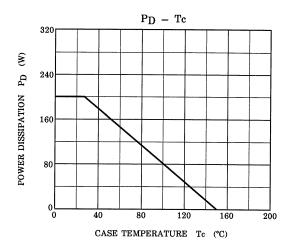


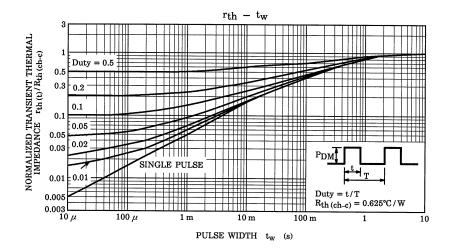


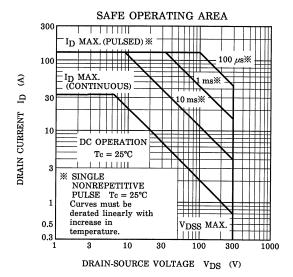












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